

Search Notes



Application/Control No.

10/824,510

Examiner

Hiep T. Nguyen

Applicant(s)/Patent under
Reexamination

IMS ET AL.

Art Unit

2187

SEARCHED

Class	Subclass	Date	Examiner
711	106	Text search using EAST 5/30/06 H2	
	141		
	118		
707	201		
709	203		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PG-PUB	Text	search 5/30/06 H2	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST Search His. is attached	5/30/06	H2
NPL Search using term similar to EAST search		
Inventorship search		